

# MOSFET - N-Channel, SUPERFET®

**600 V, 11 A, 380 m** $\Omega$ 

# **FCP11N60, FCPF11N60**

#### **Description**

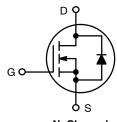
SUPERFET MOSFET is **onsemi**'s first generation of high voltage super–junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on–resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance, dv/dt rate and higher avalanche energy. Consequently, SUPERFET MOSFET is very suitable for the switching power applications such as PFC, server/telecom power, FPD TV power, ATX power and industrial power applications.

#### **Features**

- $R_{DS(on)} = 320 \text{ m}\Omega \text{ (Typ.)}$
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 40 nC)
- Low Effective Output Capacitance (Typ. C<sub>oss(eff.)</sub> = 95 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

V <sub>DS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
600 V	380 mΩ @ 10 V	11 A*	

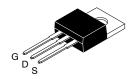
<sup>\*</sup>Drain current limited by maximum junction temperature.



N-Channel

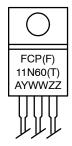


TO-220 Fullpack, 3-Lead / TO-220F-3SG CASE 221AT



TO-220-3LD CASE 340AT

#### **MARKING DIAGRAM**



FCP(F)11N60(T) = Specific Device Code A = Assembly Location YWW = Date Code (Year & Week)

ZZ = Assembly Lot

1

### **ORDERING INFORMATION**

Device	Package	Shipping
FCP11N60	TO-220-3	1000 Units / Tube
FCPF11N60	TO-220-3	1000 Units / Tube
FCPF11N60T	FullPak	

## **MOSFET MAXIMUM RATINGS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter		FCP11N60	FCPF11N60	Unit
V <sub>DSS</sub>	Drain-Source Voltage 600		600	V	
I <sub>D</sub>	Drain Current	– Continuous (T <sub>C</sub> = 25°C)	11	11*	А
		- Continuous (T <sub>C</sub> = 100°C)	7	7*	
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)	33	33*	Α
V <sub>GSS</sub>	Gate-Source Voltage		±30		V
E <sub>AS</sub>	Single Pulsed Avalanch	ne Energy (Note 2)	340		mJ
I <sub>AR</sub>	Avalanche Current (No	te 1)	11		А
E <sub>AR</sub>	Repetitive Avalanche E	nergy (Note 1)	12.5		mJ
dv/dt	Peak Diode Recovery	dv/dt (Note 3)	4.5		V/ns
$P_{D}$	Power Dissipation	(T <sub>C</sub> = 25°C)	125	36	W
		- Derate Above 25°C	1.0	0.29	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range -55 to +150		o +150	°C	
TL	Maximum Lead Tempe 1/8" from Case for 5 Se	rature for Soldering Purposes, econds	300		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality stresses exceeding those listed in the Maximum Hatings table may damage to should not be assumed, damage may occur and reliability may be affected. \*Drain current limited by maximum junction temperature. 
1. Repetitive Rating: Pulse width limited by maximum junction temperature. 
2.  $I_{AS} = 5.5 \text{ A}$ ,  $V_{DD} = 50 \text{ V}$ ,  $R_{G} = 25 \Omega$ , starting  $T_{J} = 25^{\circ}\text{C}$ . 
3.  $I_{SD} \le 11 \text{ A}$ ,  $I_{S$ 

#### THERMAL CHARACTERISTICS

Symbol	Parameter	FCP11N60	FCPF11N60	Unit
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	1.0	3.5	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.5	-	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	°C/W

# **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS		•	•		
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA, T <sub>J</sub> = 25°C	600	_	_	V
		V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA, T <sub>J</sub> = 150°C	-	650	_	V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 μA, Referenced to 25°C	_	0.6	_	V/°C
BV <sub>DS</sub>	Drain-Source Avalanche Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 11 A	-	700	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
		V <sub>DS</sub> = 480 V, T <sub>C</sub> = 125°C	-	-	10	
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V	-	-	100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V	-	-	-100	nA
ON CHARA	CTERISTICS	-	-	-	<u>-</u>	<u>-</u>
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	3.0	-	5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5.5 A	-	0.32	0.38	Ω
9FS	Forward Transconductance	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 5.5 A (Note 4)	-	9.7	_	S
DYNAMIC (	CHARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	1148	1490	pF
C <sub>oss</sub>	Output Capacitance	1	_	671	870	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	]	-	63	82	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 480 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	35	-	pF
C <sub>oss(eff.)</sub>	Effective Output Capacitance	V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V	-	95	_	pF
SWITCHING	G CHARACTERISTICS					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 300 \text{ V}, I_D = 11 \text{ A}, R_G = 25 \Omega$	-	34	80	ns
t <sub>r</sub>	Turn-On Rise Time	(Note 4, 5)	_	98	205	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1	_	119	250	ns
t <sub>f</sub>	Turn-Off Fall Time	1	_	56	120	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 480 V, I <sub>D</sub> = 11 A, V <sub>GS</sub> = 10 V	-	40	52	nC
Q <sub>gs</sub>	Gate-Source Charge	(Note 4, 5)	_	7.2	_	nC
Q <sub>gd</sub>	Gate-Drain Charge	1	-	21	-	nC
DRAIN-SO	URCE DIODE CHARACTERISTICS AND	MAXIMUM RATINGS				
Is	Maximum Continuous Drain-Source Diode Forward Current		-	-	11	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode Forward Current		-	-	33	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 11 A	-	-	1.4	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 11 \text{ A}, dI_{F}/dt = 100 \text{ A}/\mu\text{s}$	-	390	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	(Note 4)	_	5.7	_	μС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: Pulse width ≤ 300 µs, Duty cycle ≤ 2%

5. Essentially independent of operating temperature

#### TYPICAL PERFORMANCE CHARACTERISTICS

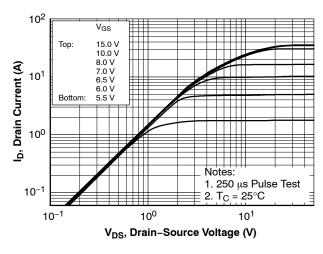


Figure 1. On-Region Characteristics

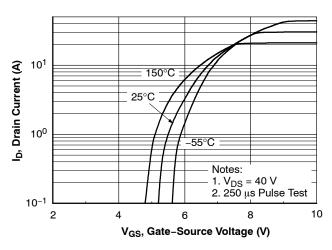


Figure 2. Transfer Characteristics

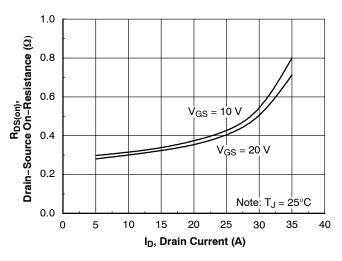


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

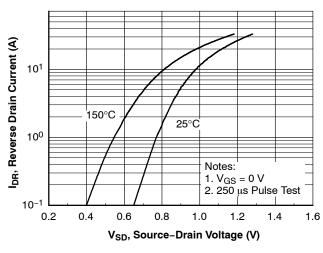


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

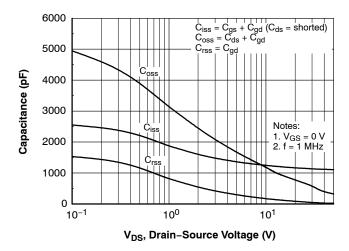


Figure 5. Capacitance Characteristics

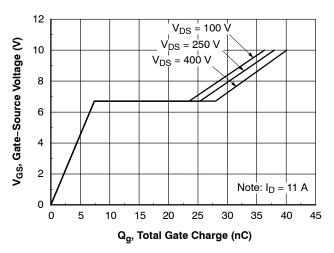


Figure 6. Gate Charge Characteristics

#### TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

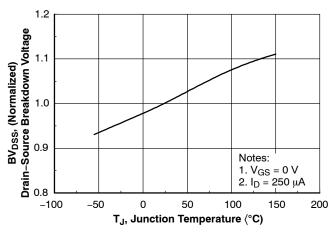


Figure 7. Breakdown Voltage Variation vs. Temperature

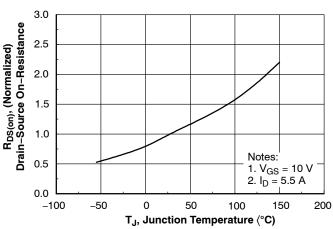


Figure 8. On–Resistance Variation vs. Temperature

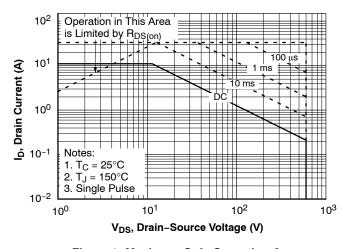


Figure 9. Maximum Safe Operating Area for FCP11N60

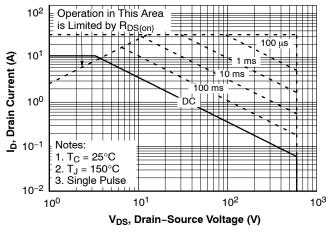


Figure 10. Maximum Safe Operating Area for FCPF11N60

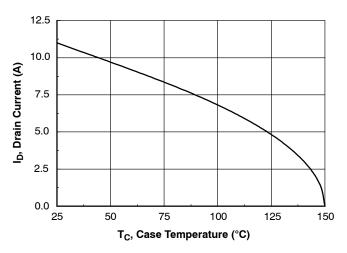


Figure 11. Maximum Drain Current vs. Case Temperature

# TYPICAL PERFORMANCE CHARACTERISTICS (continued)

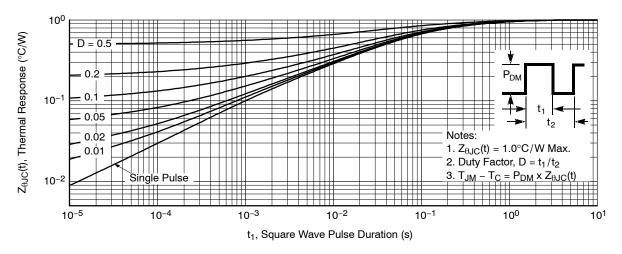


Figure 12. Transient Thermal Response Curve for FCP11N60

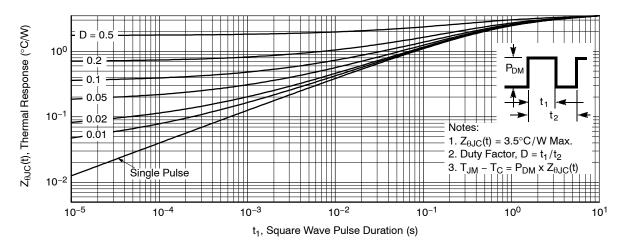


Figure 13. Transient Thermal Response Curve for FCPF11N60

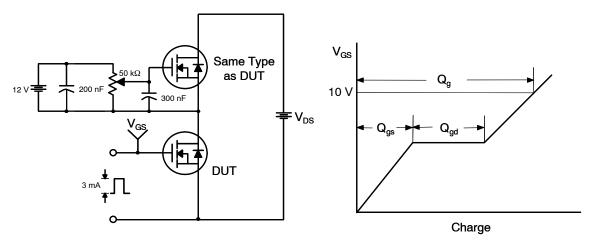


Figure 14. Gate Charge Test Circuit & Waveform

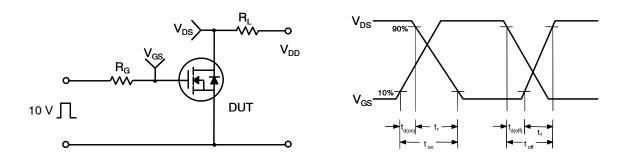


Figure 15. Resistive Switching Test Circuit & Waveforms

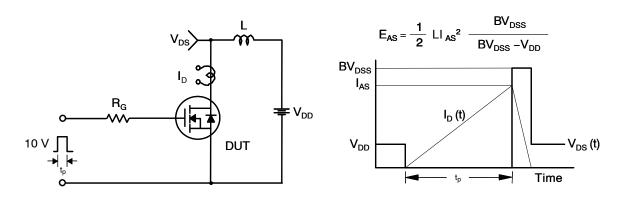
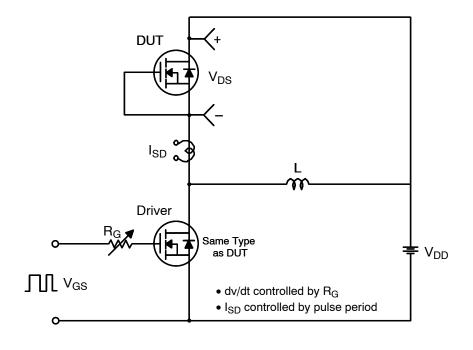


Figure 16. Unclamped Inductive Switching Test Circuit & Waveforms



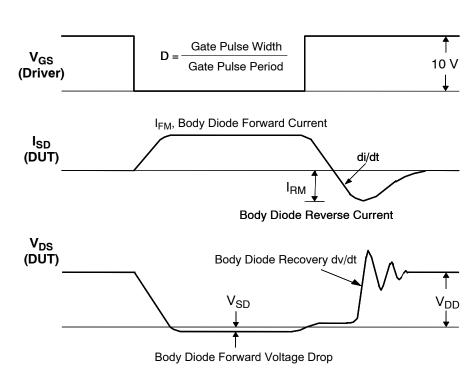
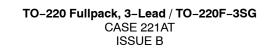
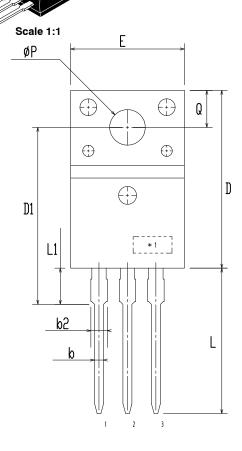


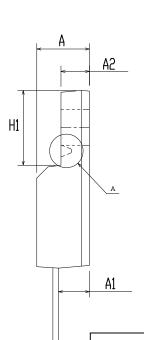
Figure 17. Peak Diode Recovery dv/dt Test Circuit & Waveforms

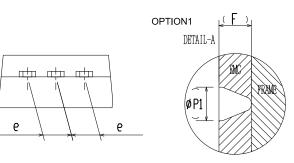
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**DATE 19 JAN 2021** 







DIM	MIL	LIMITERS	
DIM	MIN	NDM	MAX
Α	4.50	4.70	4.90
A1	2.56	2.76	2.96
A2	2.34	2.54	2.74
b	0.70	0.80	0.90
b2	*	2	1.47
C	0.45	0.50	0.60
D	15.67	15.87	16.07
D1	15.60	15.80	16.00
E	9.96	10.16	10.36
е	2.34	2.54	2.74
F	~	0.84	~
H1	6.48	6.68	6.88
Ш	12.78	12.98	13.18
L1	3.03	3.23	3.43
ØΡ	2.98	3.18	3.38
Ø P1	~	1.00	~
Q	3.20	3.30	3.40

#### NOTES:

- A. DIMENSION AND TOLERANCE AS ASME Y14.5-2009
- B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUCSIONS.

C

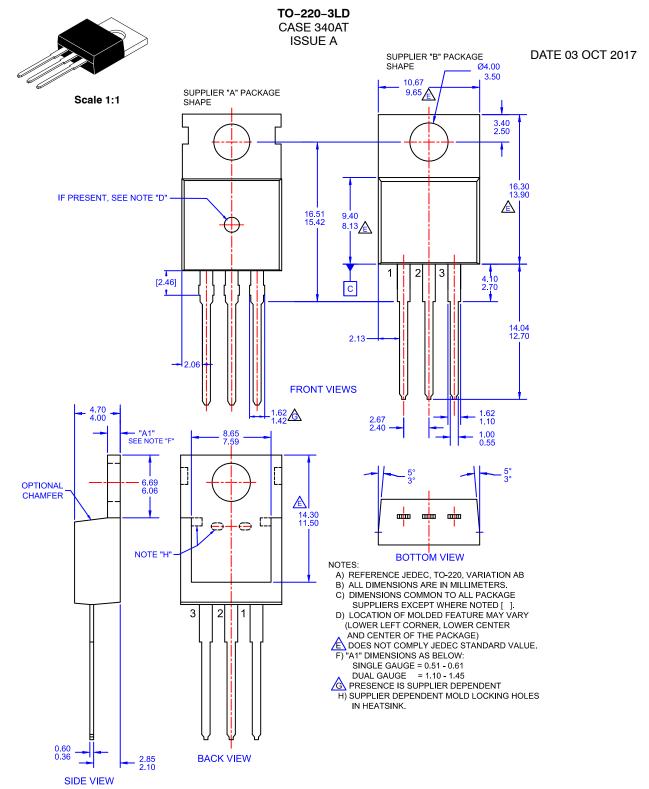
C. OPTION 1 - WITH SUPPORT PIN HOLE

OPTION 2 - NO SUPPORT PIN HOLE

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